

# STx25NM60ND

N-channel 600 V, 0.13 Ω, 21 A FDmesh™ II Power MOSFET (with fast diode) in D<sup>2</sup>PAK, TO-220FP, TO-220, TO-247

### Features

Туре	V <sub>DSS</sub> @ T <sub>JMAX</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STB25NM60ND			21 A
STF25NM60ND	650 V	0.16 Ω	21 A <sup>(1)</sup>
STP25NM60ND			21 A
STW25NM60ND			21 A

1. Limited only by maximum temperature allowed

- The worldwide best R<sub>DS(on)</sub>\*area amongst the fast recovery diode devices
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance
- Extremely high dv/dt and avalanche capabilities

### Application

Switching applications

### Description

These FDmesh<sup>™</sup> II Power MOSFETs with intrinsic fast-recovery body diode are produced using the second generation of MDmesh<sup>™</sup> technology. Utilizing a new strip-layout vertical structure, these revolutionary devices feature extremely low on-resistance and superior switching performance. They are ideal for bridge topologies and ZVS phase-shift converters.

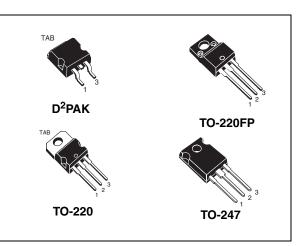
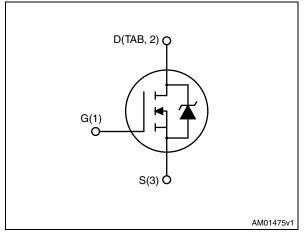


Figure 1. Internal schematic diagram



Order codes	der codes Marking		Packaging
STB25NM60ND	25NM60ND	D <sup>2</sup> PAK	Tape and reel
STF25NM60ND	25NM60ND	TO-220FP	Tube
STP25NM60ND	25NM60ND	TO-220	Tube
STW25NM60ND	25NM60ND	TO-247	Tube

Doc ID 14167 Rev 5

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## 1 Electrical ratings

Table 2.	Absolute	maximum ratings	5
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		Value		
Symbol	Parameter	D <sup>2</sup> PAK, TO-220, TO-247	220, TO-220FP	
V <sub>DS</sub>	Drain-source voltage 600		V	
V <sub>GS</sub>	Gate-source voltage	±25		V
I <sub>D</sub>	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$	21 21 <sup>(1)</sup>		Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C 13		13 <sup>(1)</sup>	Α
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	84	84(1)	Α
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \ ^{\circ}C$	160	40	W
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	40		V/ns
Viso	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s;T <sub>C</sub> =25 °C)		2500	v
T <sub>stg</sub>	Storage temperature	-55 to 150		°C
Τ <sub>J</sub>	Max. operating junction temperature 150		°C	

1. Limited only by maximum temperature allowed

2. Pulse width limited by safe operating area

3. I\_{SD}  $\,\leq$  21 A, di/dt  $\,\leq$  600 A/µs, V\_{DD} = 80% V\_(BR)DSS

#### Table 3. Thermal data

Symbol	Parameter	D <sup>2</sup> PAK	TO-220FP	TO-220	TO-247	Unit
R <sub>thj-case</sub>	Thermal resistance junction- case max	0.78	3.1	0.78		°C/W
R <sub>thj-amb</sub>	Thermal resistance junction- ambient max		62.5		50	°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction- ambient max	30				°C/W

1. When mounted on 1inch<sup>2</sup> FR-4 board, 2 oz Cu

#### Table 4.Avalanche characteristics

Symbol	Parameter	Max value	Unit
I <sub>AS</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_J$ max)	10	А
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}$ , $I_D = I_{AS}$ , $V_{DD} = 50 \text{ V}$ )	850	mJ



### 2 Electrical characteristics

(T<sub>CASE</sub>=25 °C unless otherwise specified).

Table 5. On/off states	
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Symbol	Parameter	Test conditions	Value			Unit
Symbol		Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_{D} = 1 \text{ mA}, V_{GS} = 0$	600			V
dv/dt <sup>(1)</sup>	Drain source voltage slope	$V_{DD}$ = 480 V, I <sub>D</sub> = 21 A, $V_{GS}$ = 10 V		48		V/ns
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 600 V V <sub>DS</sub> = 600 V @T <sub>C</sub> = 125 °C			1 100	μΑ μΑ
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	3	4	5	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10.5 A		0.13	0.16	Ω

1. Characteristic value at turn off on inductive load.

Table 0.	Dynamic					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	$V_{DS} = 15 V_{,} I_{D} = 10.5 A$	-	17	-	S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> = 50 V, f = 1 MHz, V <sub>GS</sub> = 0	-	2400 150 15	-	pF pF pF
C <sub>oss eq.</sub> <sup>(2)</sup>	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0$ to 480 V	-	320	-	pF
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 300 \text{ V}, I_D = 10.5 \text{ A}$ $R_G = 4.7 \Omega V_{GS} = 10 \text{ V}$ (see Figure 23), (see Figure 18)	-	60 30 50 40	-	ns ns ns ns
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 480 \text{ V}, I_D = 21 \text{ A},$ $V_{GS} = 10 \text{ V},$ (see Figure 19)	-	80 15 40	-	nC nC nC
Rg	Gate input resistance	f=1 MHz gate DC bias=0 Test signal level = 20 mV open drain	-	1.6	-	Ω

Table 6. Dynamic

1. Pulsed: pulse duration=300 $\mu$ s, duty cycle 1.5%

2.  $C_{oss\ eq}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)		-		21 84	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 21 A, V <sub>GS</sub> = 0	-		1.3	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 21 \text{ A}, V_{DD} = 60 \text{ V}$ di/dt=100 A/ $\mu$ s (see Figure 20)	-	160 1 15		ns μC Α
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 21 \text{ A}, V_{DD} = 60 \text{ V}$ di/dt=100 A/µs, T <sub>J</sub> = 150 °C (see Figure 20)	-	230 2 19		ns μC Α

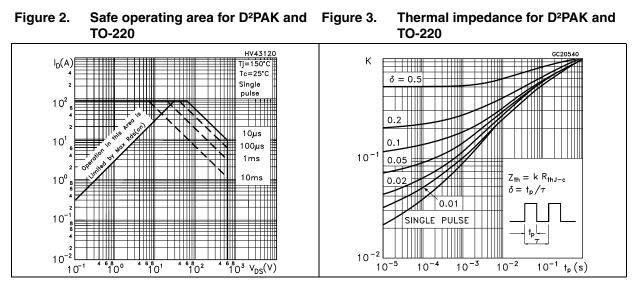
Table 7.Source drain diode

1. Pulse width limited by safe operating area

2. Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5%.



### 2.1 Electrical characteristics (curves)





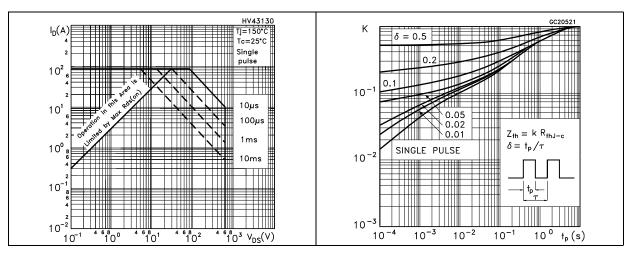
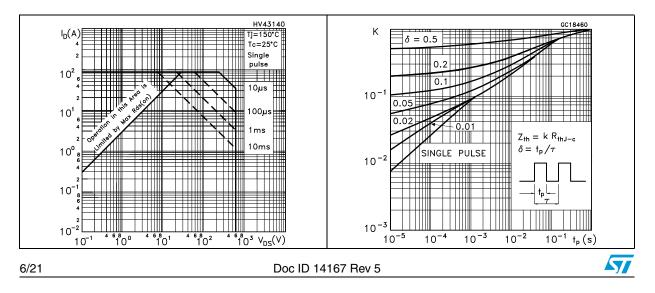


Figure 5.

Figure 6. Safe operating area for TO-247



Thermal impedance for TO-220FP



#### Figure 8. Output characteristics

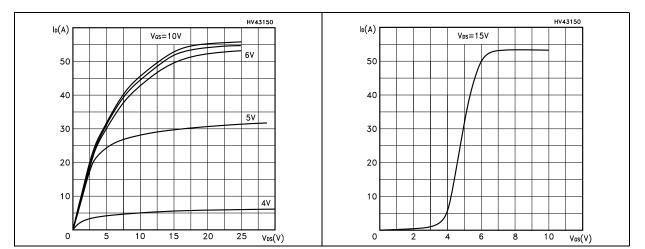
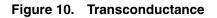
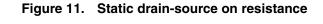


Figure 9.





**Transfer characteristics** 

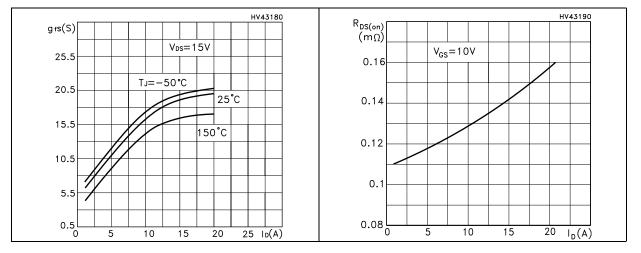
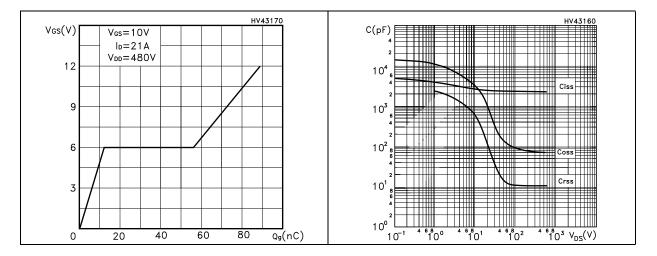


Figure 12. Gate charge vs gate-source voltage Figure 13. Capacitance variations





#### Figure 14. Normalized gate threshold voltage Figure 15. vs temperature

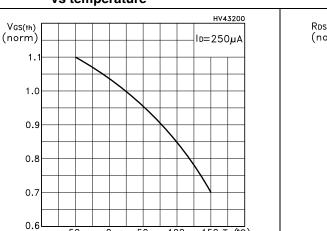
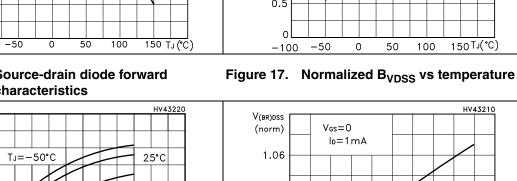
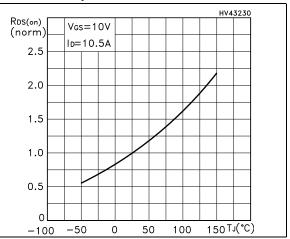
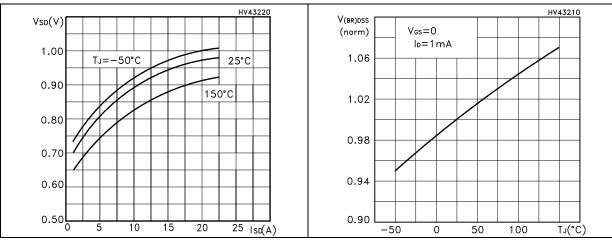


Figure 16. Source-drain diode forward characteristics



#### Normalized on resistance vs temperature

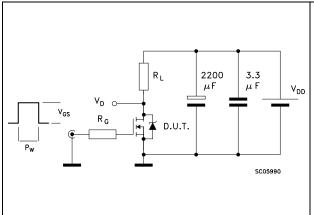






### 3 Test circuits

Figure 18. Switching times test circuit for resistive load



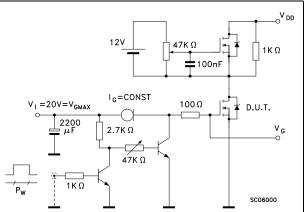
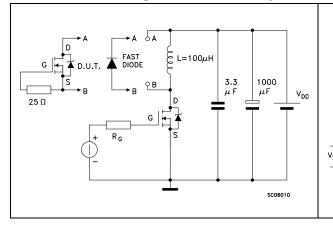


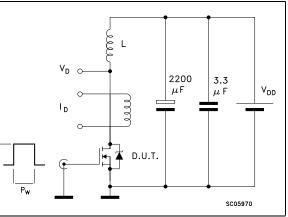
Figure 19. Gate charge test circuit

Figure 20. Test circuit for inductive load switching and diode recovery times

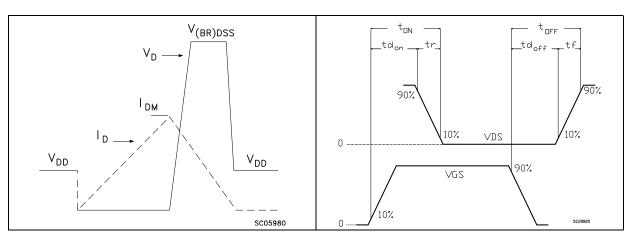














### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

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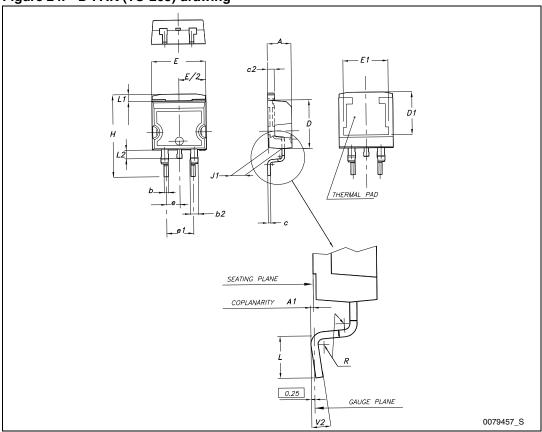


	D <sup>2</sup> PAK (TO-263) mechanical data			
Dim.	mm			
	Min.	Тур.	Max.	
Α	4.40		4.60	
A1	0.03		0.23	
b	0.70		0.93	
b2	1.14		1.70	
с	0.45		0.60	
c2	1.23		1.36	
D	8.95		9.35	
D1	7.50			
Е	10		10.40	
E1	8.50			
е		2.54		
e1	4.88		5.28	
Н	15		15.85	
J1	2.49		2.69	
L	2.29		2.79	
L1	1.27		1.40	
L2	1.30		1.75	
R		0.4		
V2	0°		8°	

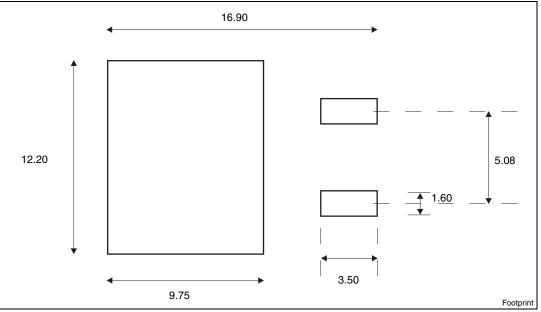
 Table 8.
 D<sup>2</sup>PAK (TO-263) mechanical data











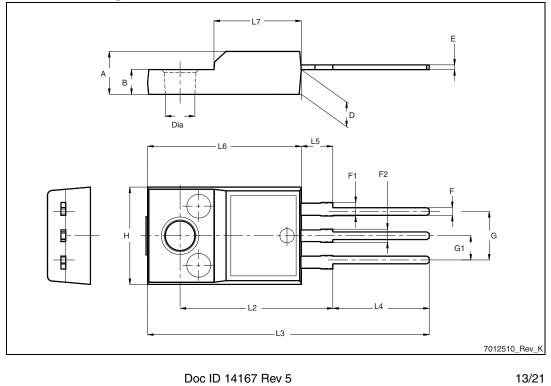
a. All dimension are in millimeters



Dim.	mm			
Dim.	Min.	Тур.	Max.	
А	4.4		4.6	
В	2.5		2.7	
D	2.5		2.75	
E	0.45		0.7	
F	0.75		1	
F1	1.15		1.70	
F2	1.15		1.70	
G	4.95		5.2	
G1	2.4		2.7	
Н	10		10.4	
L2		16		
L3	28.6		30.6	
L4	9.8		10.6	
L5	2.9		3.6	
L6	15.9		16.4	
L7	9		9.3	
Dia	3		3.2	

Table 9.TO-220FP mechanical data

#### TO-220FP drawing

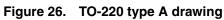


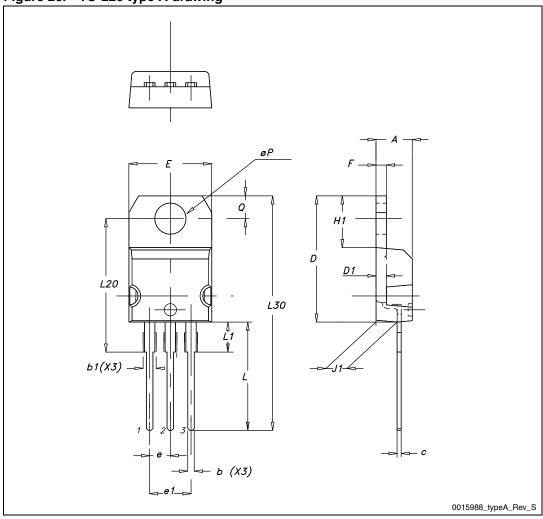
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 Table 10.
 TO-220 type A mechanical data

Dim.	mm			
	Min.	Тур.	Max.	
А	4.40		4.60	
b	0.61		0.88	
b1	1.14		1.70	
с	0.48		0.70	
D	15.25		15.75	
D1		1.27		
E	10		10.40	
е	2.40		2.70	
e1	4.95		5.15	
F	1.23		1.32	
H1	6.20		6.60	
J1	2.40		2.72	
L	13		14	
L1	3.50		3.93	
L20		16.40		
L30		28.90		
ØР	3.75		3.85	
Q	2.65		2.95	









Dim.	mm.			
Dim.	Min.	Тур.	Max.	
A	4.85		5.15	
A1	2.20		2.60	
b	1.0		1.40	
b1	2.0		2.40	
b2	3.0		3.40	
с	0.40		0.80	
D	19.85		20.15	
E	15.45		15.75	
е	5.30	5.45	5.60	
L	14.20		14.80	
L1	3.70		4.30	
L2		18.50		
ØP	3.55		3.65	
ØR	4.50		5.50	
S	5.30	5.50	5.70	

Table 11. TO-247 mechanical data

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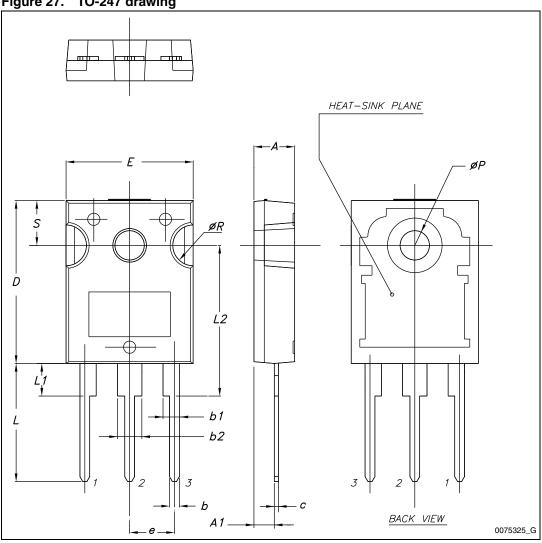


Figure 27. TO-247 drawing

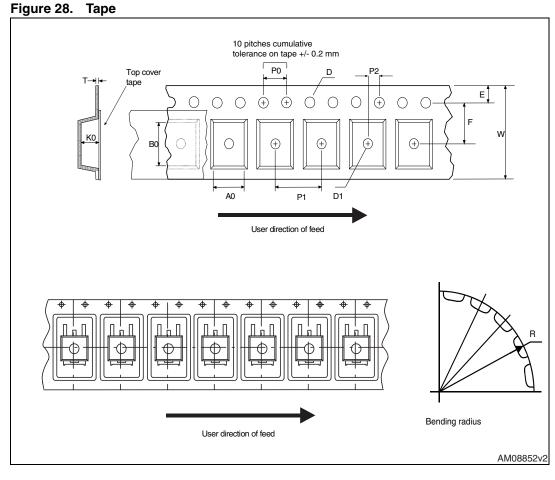


## 5 Packing mechanical data

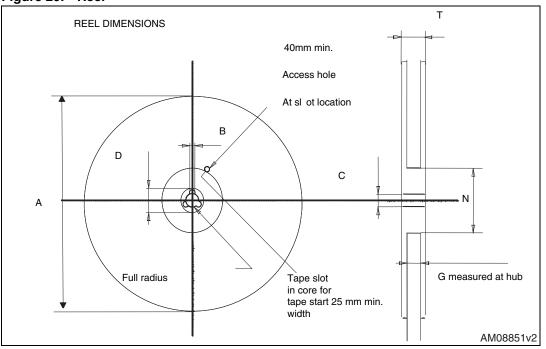
Таре			Reel		
Dim. —	mm		Dim	mm	
	Min.	Max.	— Dim. –	Min.	Max.
A0	10.5	10.7	А		330
B0	15.7	15.9	В	1.5	
D	1.5	1.6	С	12.8	13.2
D1	1.59	1.61	D	20.2	
Е	1.65	1.85	G	24.4	26.4
F	11.4	11.6	N	100	
K0	4.8	5.0	Т		30.4
P0	3.9	4.1			
P1	11.9	12.1		Base qty	1000
P2	1.9	2.1		Bulk qty	1000
R	50				
Т	0.25	0.35			
W	23.7	24.3			

 Table 12.
 D<sup>2</sup>PAK (TO-263) tape and reel mechanical data











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## 6 Revision history

Table 13.	Document revision history
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Date	Revision	Changes
15-Nov-2007	1	First release.
22-Jan-2008	2	Document status promoted from target specification to preliminary data.
08-Apr-2008	3	<ul> <li>Updated <i>Table 3: Thermal data on page 3</i>;</li> <li>Document status promoted from preliminary data to datasheet.</li> </ul>
03-Mar-2009	4	Q <sub>g</sub> value has been updated.
28-Nov-2011	5	Updated Section 4: Package mechanical data and Section 5: Packing mechanical data. Minor text changes.



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